(Form PTO-1449 [6-4])

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Form-PTO-1449	PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. 298-278		SERIAL NO. 10/521,516			
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/SAT/	GIULIANI et al couplers," J. O	GIULIANI et al., "Spectral characteristics of laser cavities employing multipass grating interferometers as output couplers," J. Opt. Soc. Am.B., Vol. 4, No. 11, Nov. 1987, Pp. 1781-1789.						
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EXAMINER /Samuel A. Turner/			DATE CONSIDERED					
			10/31/2007					
* EXAMINER: In	nitial if reference considered, gh citation if not in conforman	whether or not citation are and not considered.	is in conformance with MPI Include copy of this form v	EP 609. with next				
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